

- **Coherence of light and matter:
from basic concepts to modern applications**

Part III: G. Grübel

Script 3

Coherence based X-ray techniques

Overview, Introduction to X-ray Scattering, Sources of Coherent X-rays, Speckle pattern and their analysis

Imaging techniques

Phase Retrieval, Sampling Theory, Reconstruction of Oversampled Data, Fourier Transform Holography, Applications

X-ray Photon Correlation Spectroscopy (XPCS)

Introduction, Equilibrium Dynamics (Brownian Motion), Surface Dynamics, Non-Equilibrium Dynamics

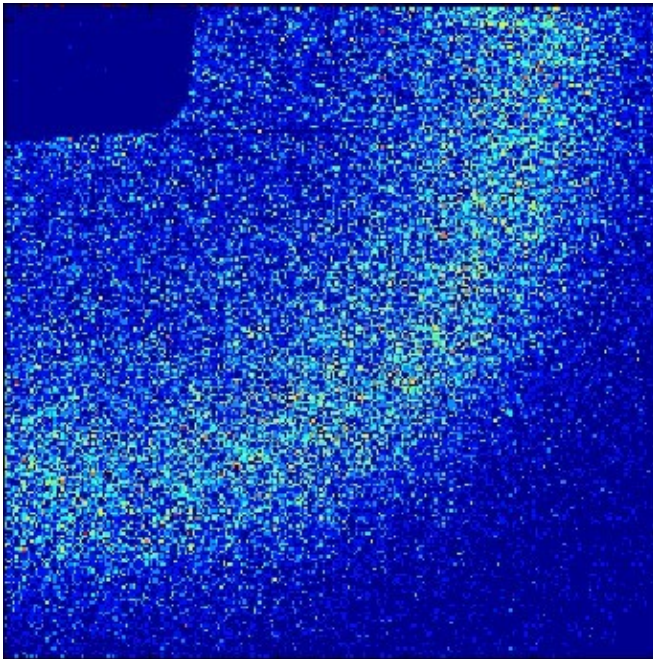
Imaging and XPCS at FEL Sources

(Lensless) Imaging

If coherent light is scattered from a disordered system it gives rise to a random (grainy) diffraction pattern, known as “speckle”. A speckle pattern is an interference pattern and related to the exact spatial arrangement of the scatterers in the disordered system.

$$I(Q,t) \sim S_c(Q,t) \sim \left| \sum_j e^{iQR_j(t)} \right|^2$$

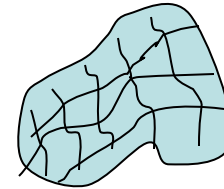
j in coherence volume $c = \xi_t^2 \xi_l$



phase information
is lost

Phase Retrieval and Oversampling

without a priori information eq. (\$) cannot be solved uniquely
== > decrease number of unknown variables:



object elements with known scattering density (e.g. zero)

i) use objects with some known scattering density

$\sigma = \text{total number of elements} / \text{number of unknown-valued pixels} > 2$

ii) increase number of known quantities in eq. (\$) by “oversampling”
sample the magnitude of a Fourier transform finely enough to get a finite support for the object such that the element values outside the finite support is zero

need: $\sigma > 2$ in 1D; $\sigma > 2^{1/2}$ in 2D; $\sigma > 2^{1/3}$ in 3D

iii) apply iterative algorithms to retrieve phase

iv) resolution determined by maximum momentum transfer Q

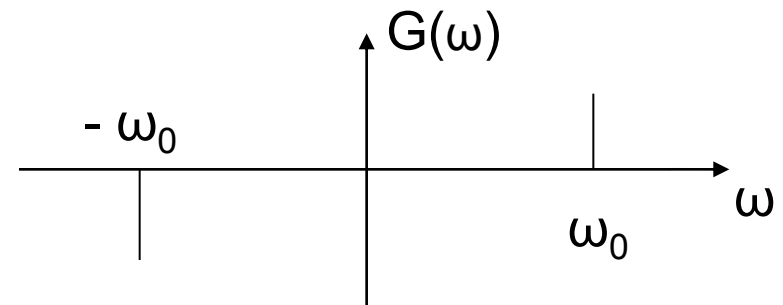
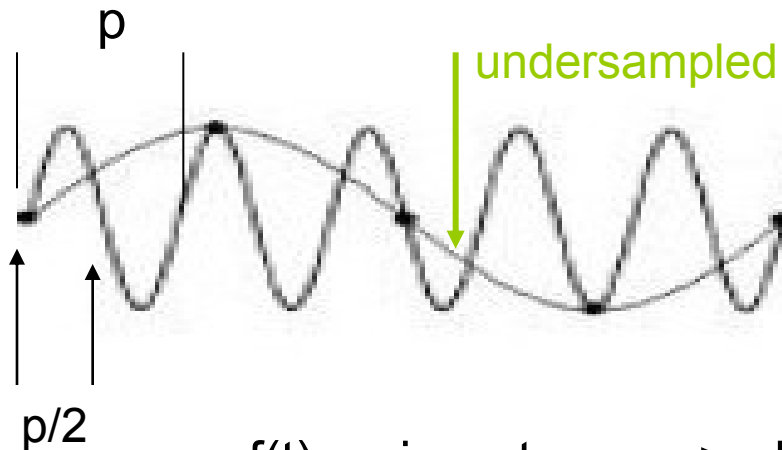
Sampling Theory (1)

Sampling Theorem:

A signal $f(t)$ that is

i) bandwidth limited

ii) sampled above the Nyquist frequency is completely determined by its samples.



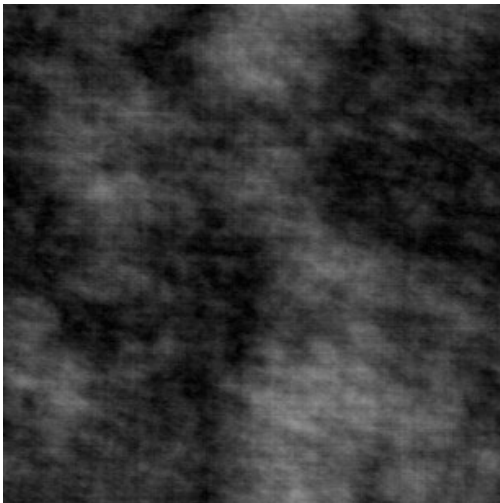
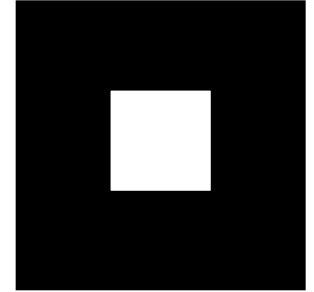
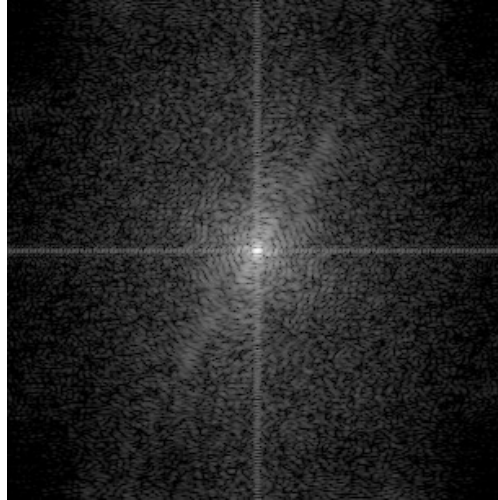
$$f(t) = \sin \omega_0 t \quad \Longleftrightarrow \quad \text{FT} \quad \Longleftrightarrow \quad G(\omega) = \int f(t) e(-i2\pi\omega t) dt$$

A signal is called bandwidth limited if it contains no frequencies outside the interval: $[-f_{\max}, f_{\max}]$. Here $f_{\max} (= \omega_0)$ is called the bandwidth of the function. The Nyquist frequency is usually given by $f_{\text{NY}} = 2 f_{\max} (= 2\omega_0)$.

Note: period $p = 2\pi/\omega_0$ and (Nyquist) sampling period $p_{\text{NY}} = 2\pi/2\omega_0 = p/2$.
(undersampling: $p > p_{\text{NY}}$; oversampling: $p < p_{\text{NY}}$)

Reconstructing the real space structure – the main principle

Gerchberg&Saxton(1972); Fienup (1982)



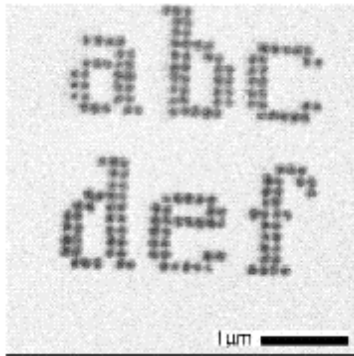
courtesy L. Stadler

- 1. Guess support in real space
0. Add random phases to measured amplitudes
1. FT into real space
2. Set pixels outside support to zero and use positivity
3. FT into fourier space
4. Substitute amplitudes with measured values

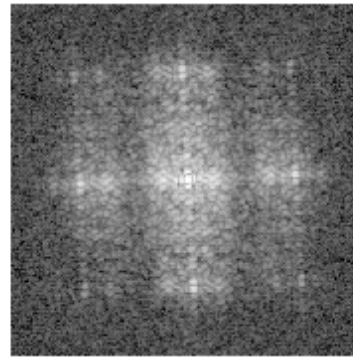
Loop over steps 1-4

Reconstruction of „oversampled“ data (1)

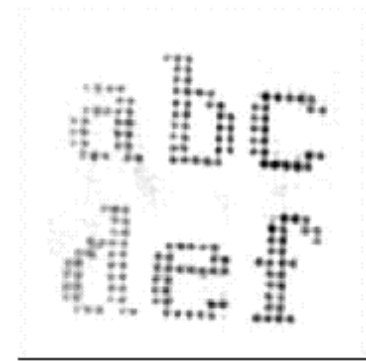
Reconstruction (phasing) of a speckle pattern: “oversampling” technique



gold dots on SiN membrane
(0.1 μm diameter, 80 nm thick)



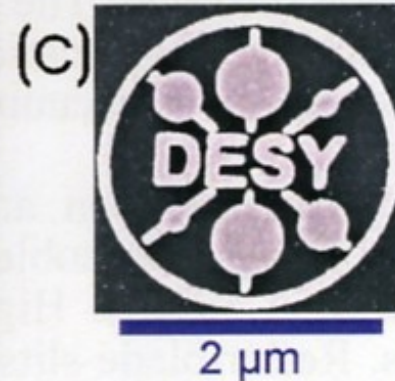
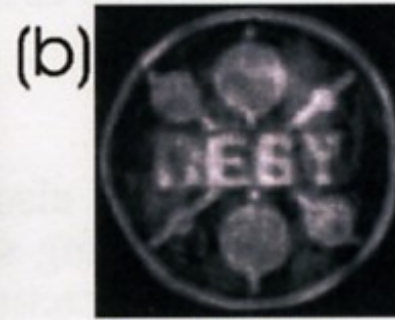
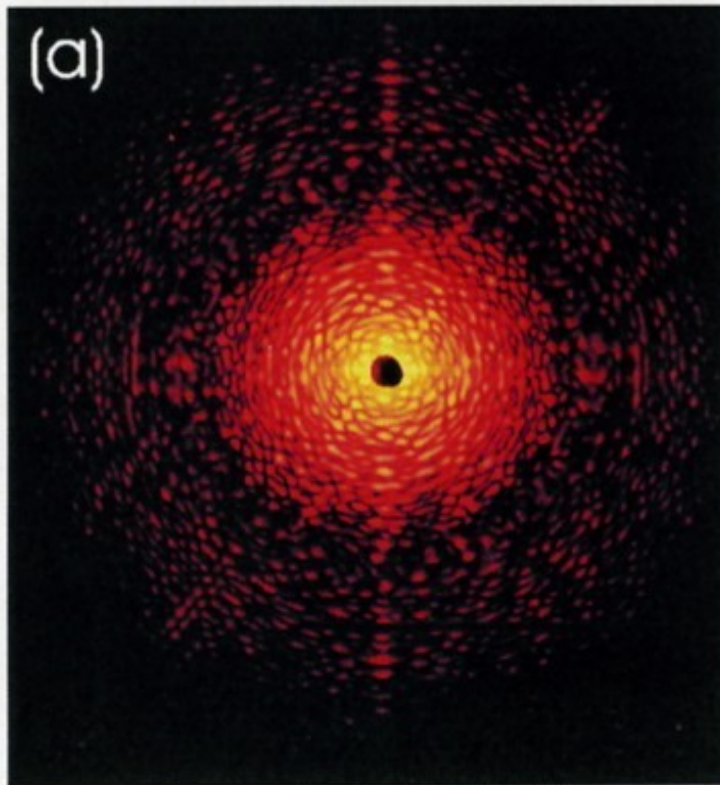
$\lambda=17\text{\AA}$ coherent beam at X1A
(NSLS), $1.3 \cdot 10^9$ ph/s $10\mu\text{m}$ pinhole
 $24\mu\text{m} \times 24\mu\text{m}$ pixel CCD



reconstruction
“oversampling” technique

Miao, Charalambous, Kirz, Sayre, Nature, 400, July 1999

Reconstruction of “oversampled” data (3)



E= 8 keV ID10C (ESRF)

10x10 μm² beam

200 nm height gold structures on 50nm Si₃N₄ membrane (c: SEM)

1242x1152 pixel, 22.5 μm² pixel CCD in 3.29 m

200 x 3 s exposure (a)

Reconstruction (average of 4 best runs) (b)

oversampling ratio $\sigma = \text{object image} / \text{pixelsize} = (\lambda \cdot L / d) / \text{pixel} \approx 10$

speckle size = $(\lambda \cdot L / \text{aperture} = \text{object}) = 240 \mu\text{m} \approx 10 \text{ pixels}$

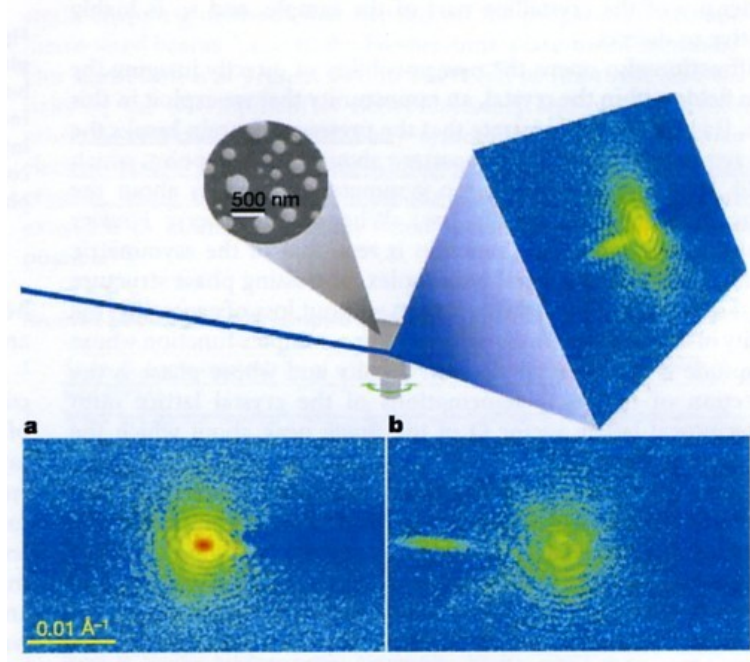
→ Extrapolate content of a missing pixel by content of neighbouring pixels!

Deformation fields inside nanocrystals

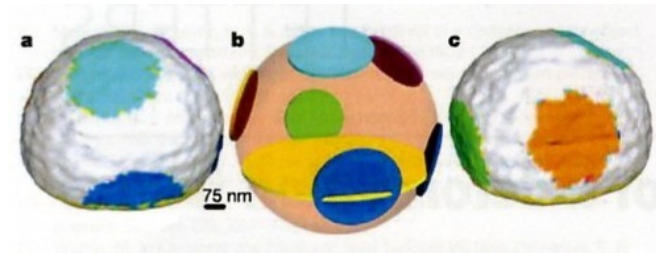
I.K. Robinson, I.A. Vartanians, G.J. Williams, M.A. Pfeifer, J.A. Pitney, Phys. Rev. Lett. 87, 195505 (2001)
M.A. Pfeifer, G.J. Williams, I.K. Vartanians, R. Harder and I.K. Robinson, Nature 442, 63 (2006)

CDI of (about 750 nm) Pb nanocrystals on Si substrate illuminated with 1.38\AA coherent x-rays and CCD tuned to the Pb (111) reflection (with 2 images separated by a 0.01 deg. rotation of the sample shown below).

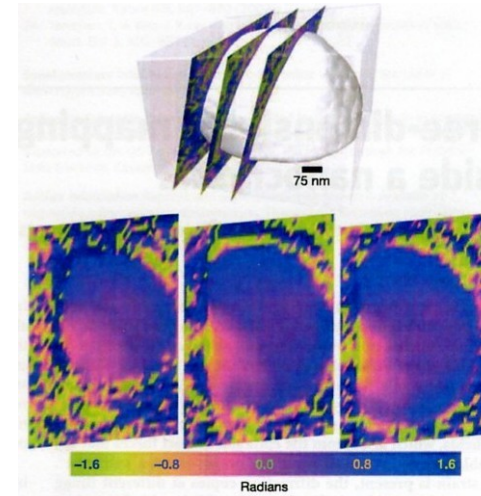
Density of crystals is regarded as a complex function with the real part being the electron density and the imaginary part representing the projection of the local deformation of the crystal onto the Q vector of the Bragg peak being measured.



Reconstructed electron density revealing (111) facets.



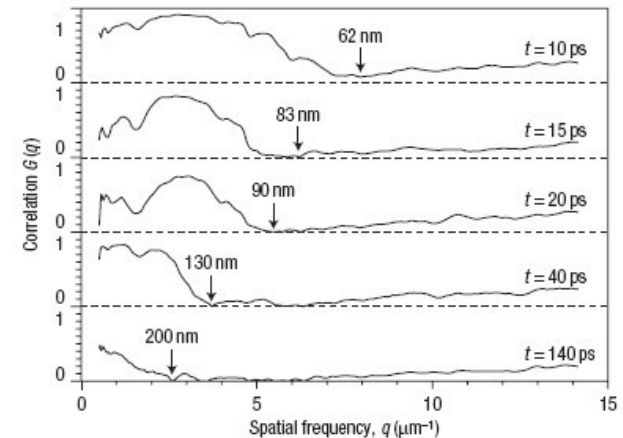
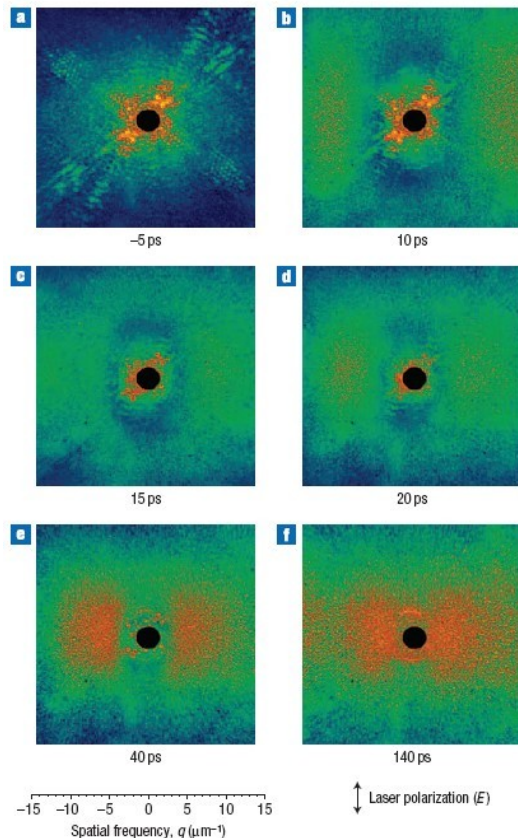
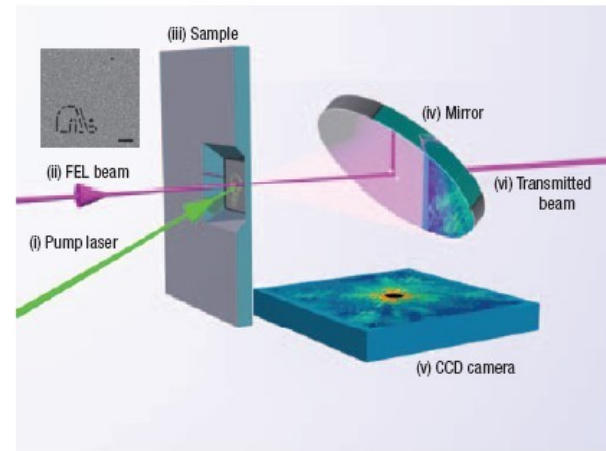
Reconstructed imaginary part revealing (in the center) a phase-shift corresponding to about $1.1/2\pi$ (111) lattice spacings or about 0.5\AA



Ultrafast single-shot diffraction imaging of nanoscale dynamics

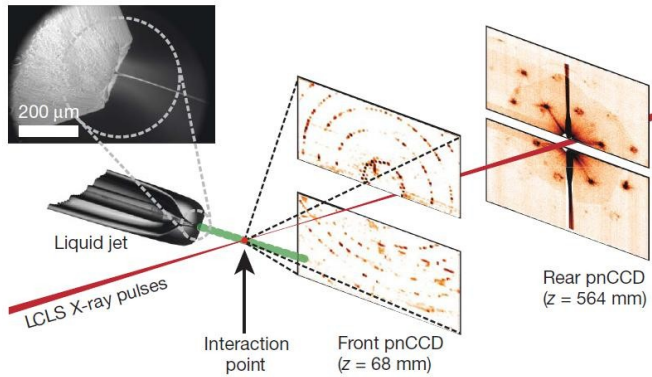
A. Barty et al., nature photonics 2, 415 (2008)

Pump-probe experiment on nano-patterned (FIP-etched) Si_3N_4 membrane (Ir-coated) pumped with Nd:YLF 523 nm, 12.5 ps long 25 μJ pulses and probed with 10 fs 13.5 nm 20 μm FLASH pulses.



Correlation functions indicate sample disintegration with a speed of about 5000-6000 m/s

Femtosecond X-ray protein nanocrystallography

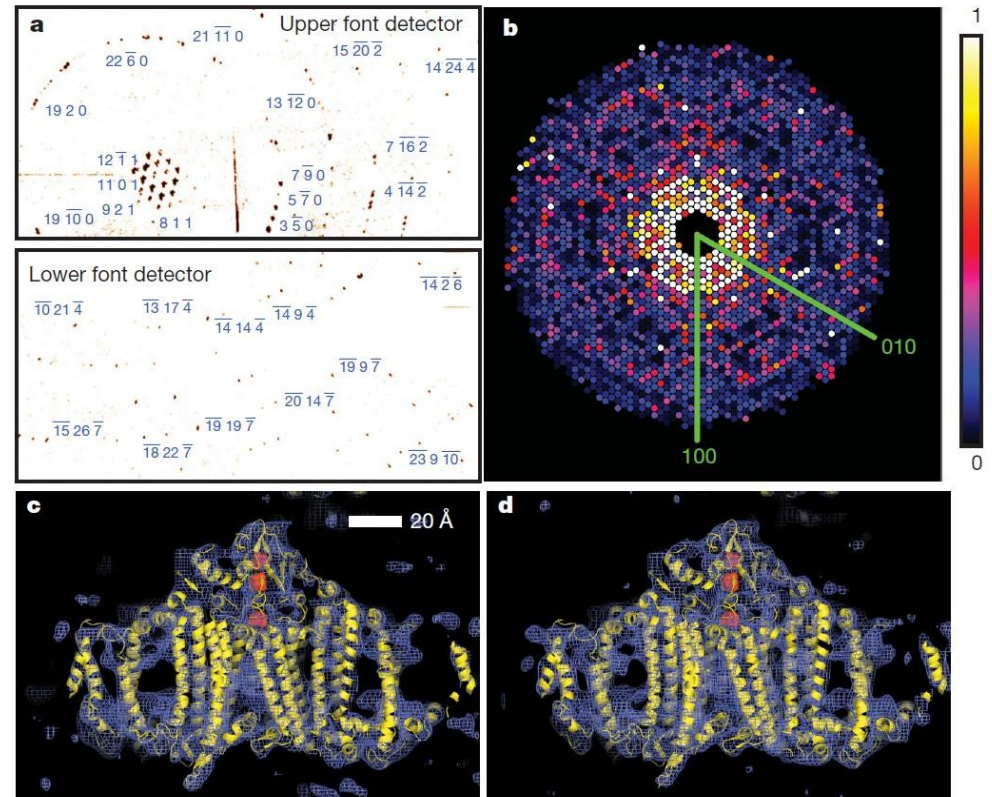


Nanocrystals (200 nm to 4 microns) of photosystem I flow in their buffer solution in a gas-focused, 4-mm-diameter jet at a velocity of 10ms/s perpendicular to the pulsed 1.8 keV X-ray FEL beam that is focused on the jet.

(a) Diffraction pattern recorded on the front pnCCDs with a single 70-fs pulse after background subtraction and correction of saturated pixels. The resolution in the lower detector corner is 8.5\AA .

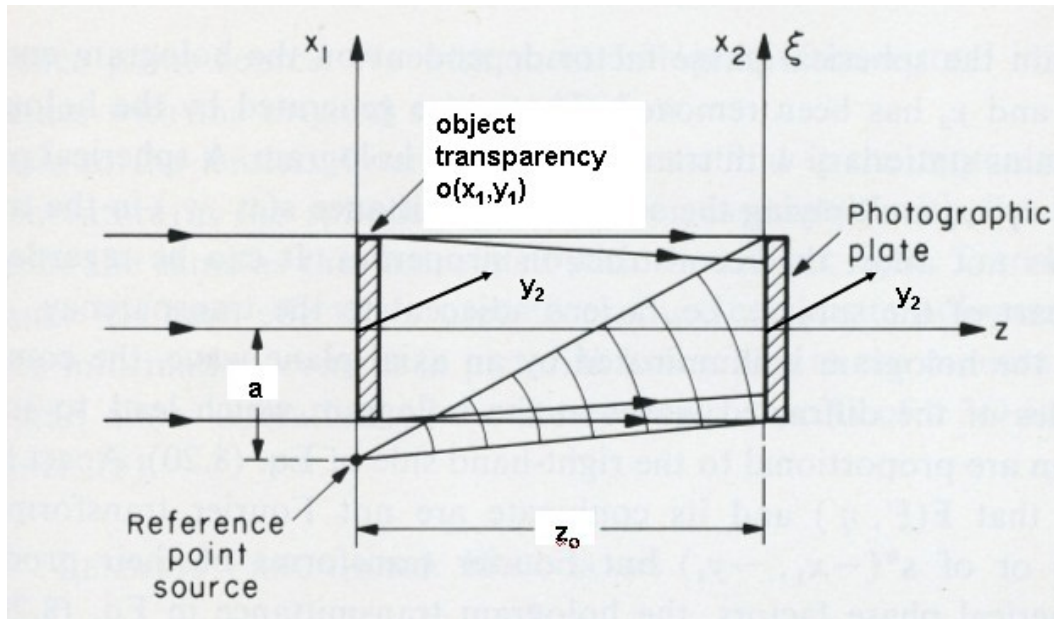
(b) Precession-style pattern of the [001] zone for photosystem I, obtained from merging femto-second nanocrystal data from over 15,000 nanocrystal patterns.

(c, d) Region of the electron density map calculated from the 70-fs data (c) and from conventional synchrotron data truncated at a resolution of 8.5\AA and collected at a temperature of 100K (d)



Henry N Chapman et al., Nature 470. 73 (2011)

Fourier Transform Holography – FTH (1)



$o(x_1, y_1)$: amplitude of the wave transmitted through object o

$r(x_1, y_1)$: reference wave

R.J. Collier, C.B. Burckhardt, L.H. Lin "Optical Holography", Academic Press (1971)

Fresnel Kirchhoff Theory

$$o(x_2, y_2) = (i/\lambda z_0) \exp\{i\pi/\lambda z_0 (x_2^2 + y_2^2)\} \bar{O}(\xi, \eta)$$

$$r(x_2, y_2) = (i/\lambda z_0) \exp\{i\pi/\lambda z_0 (x_2^2 + y_2^2)\} \check{R}(\xi, \eta) \exp\{-2i\pi\xi a\}$$

with $\bar{O}(\xi, \eta) = \text{FT}\{o(x_1, y_1)\}$, $\check{R}(\xi, \eta) = \text{FT}\{r(x_1, y_1)\}$, $\xi = x_2/\lambda z_0$, $\eta = y_2/\lambda z_0$

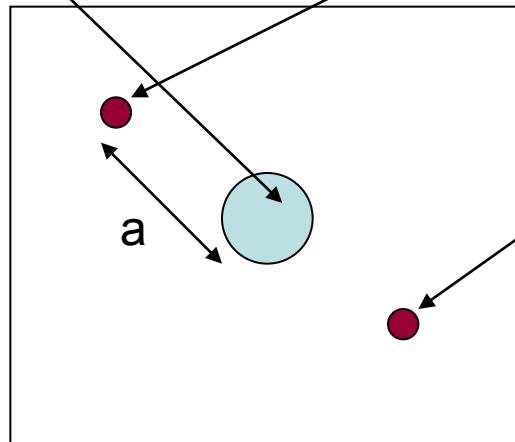
Fourier Transform Holography (2)

$$I(x_2, y_2) = |r(x_2, y_2) + o(x_2, y_2)|^2$$

$$I(x_2, y_2) = |r(x_2, y_2)|^2 + |o(x_2, y_2)|^2 + r^*(x_2, y_2) o(x_2, y_2) + r(x_2, y_2) o^*(x_2, y_2)$$

$$I(x_2, y_2) \approx \underbrace{|\check{R}(\xi, \eta)|^2}_{\text{reference}} + \underbrace{|\check{O}(\xi, \eta)|^2 + \check{R}^*(\xi, \eta) \check{O}(\xi, \eta) e^{i\pi a \xi} + \check{R}(\xi, \eta) \check{O}^*(\xi, \eta) e^{-i\pi a \xi}}_{\text{object}}$$

$$FT\{r^*(-x, -y) \otimes o(x+a, y)\} + FT\{r(x, y) \otimes o(-x-a, -y)\}$$

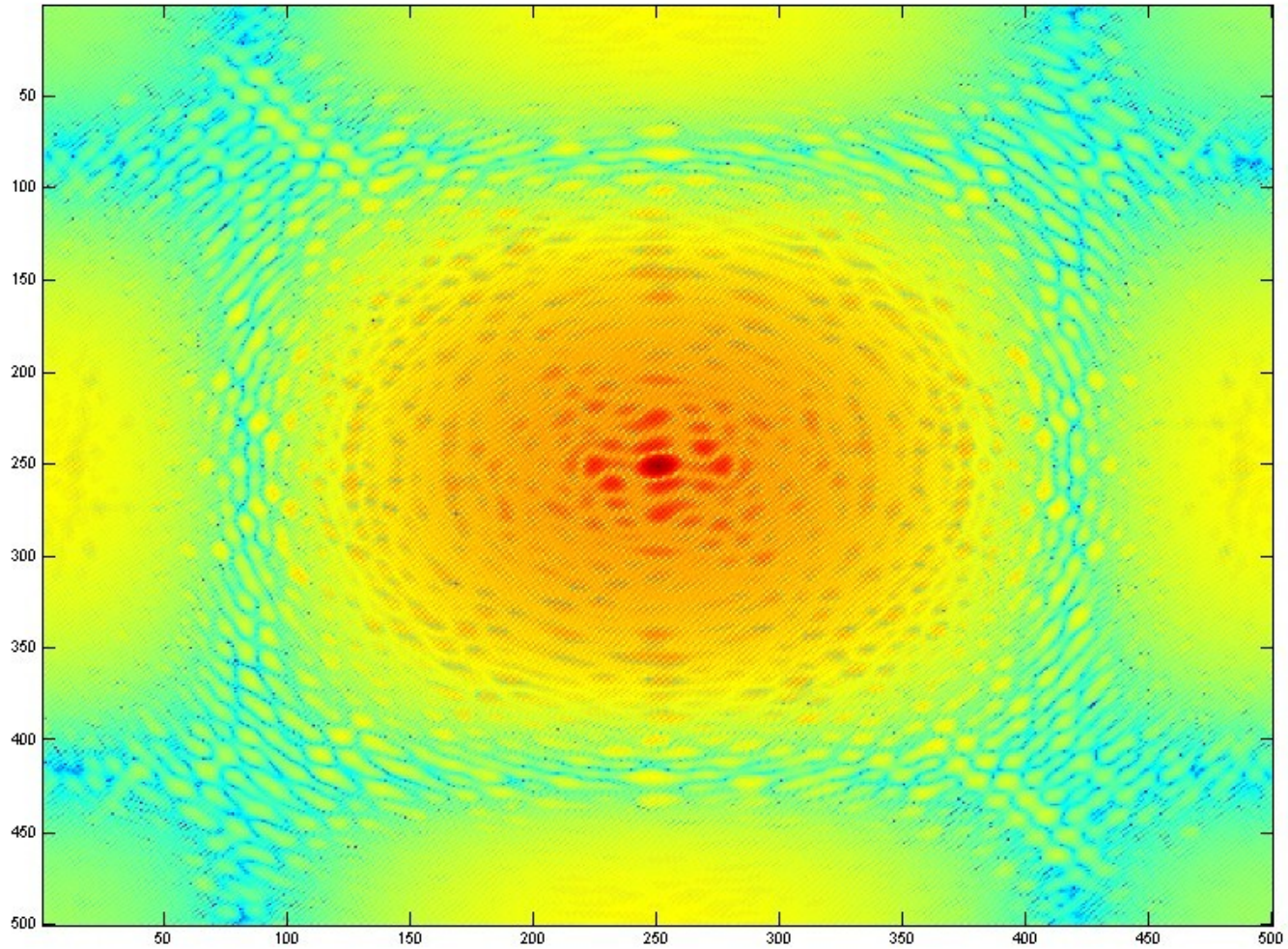


note: resolution determined by size of reference aperture

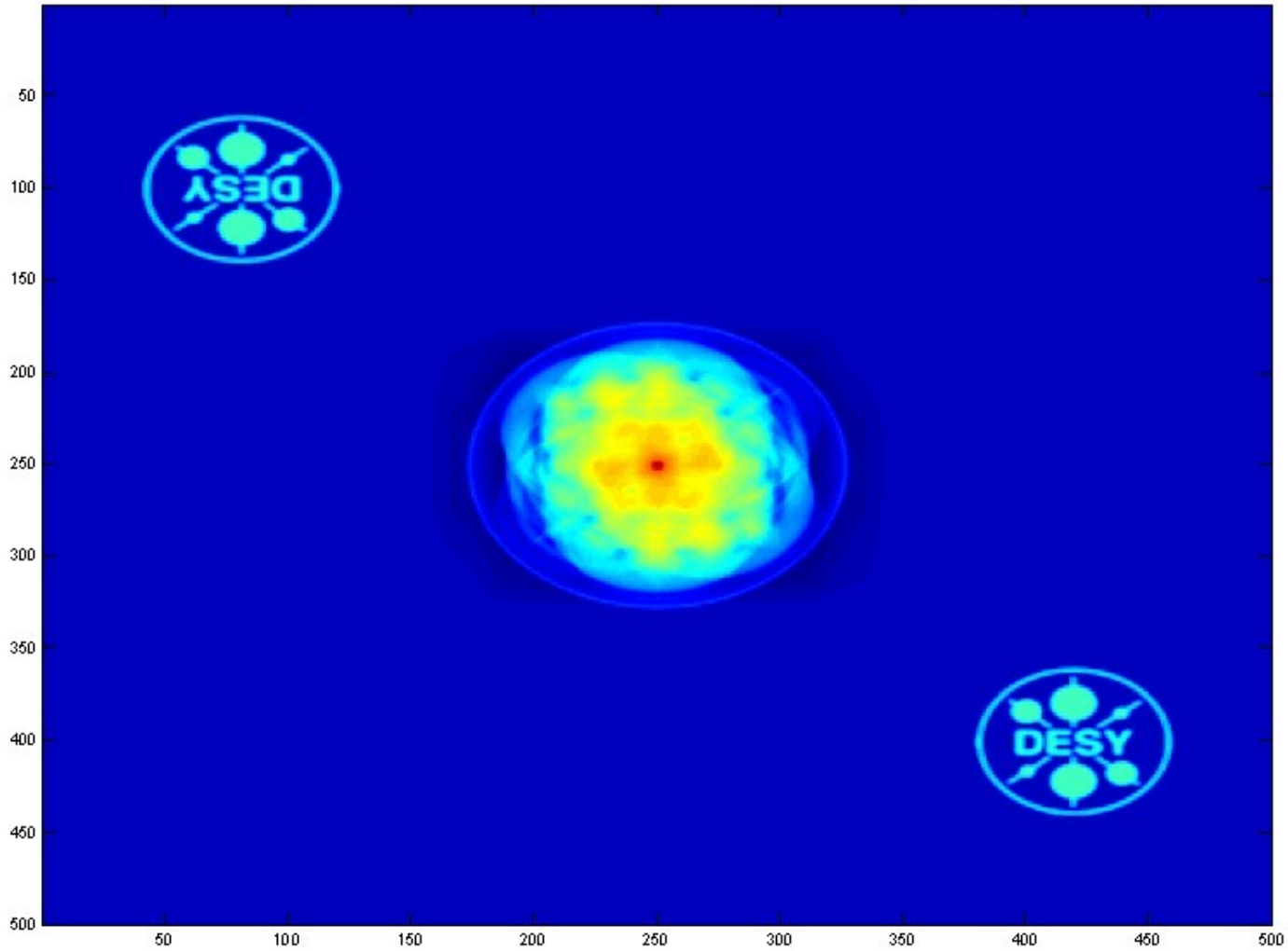
- FTH (3): small reference hole



- FTH (4)

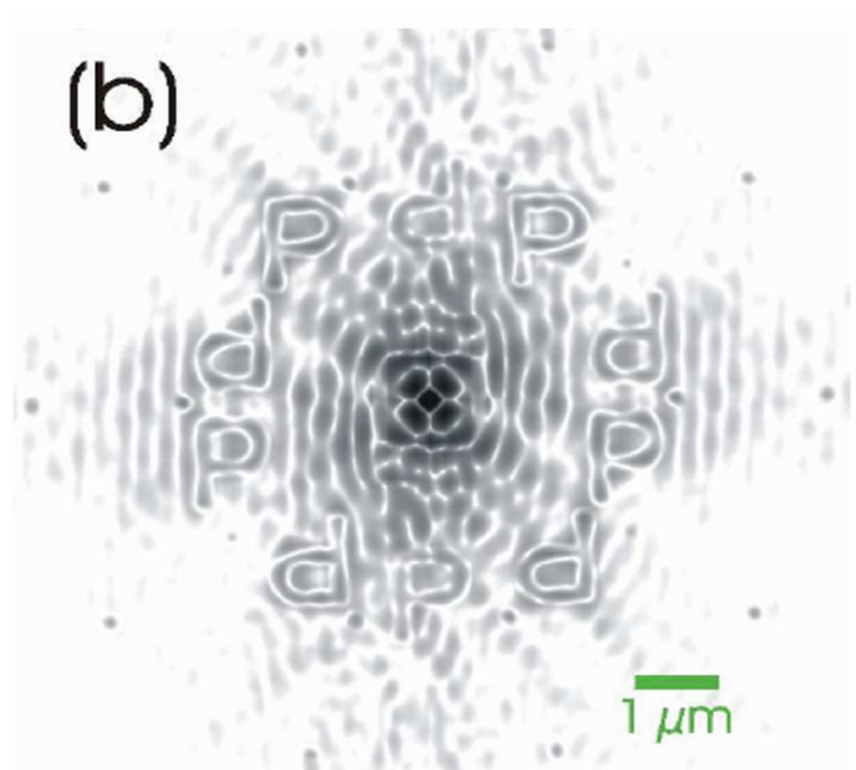
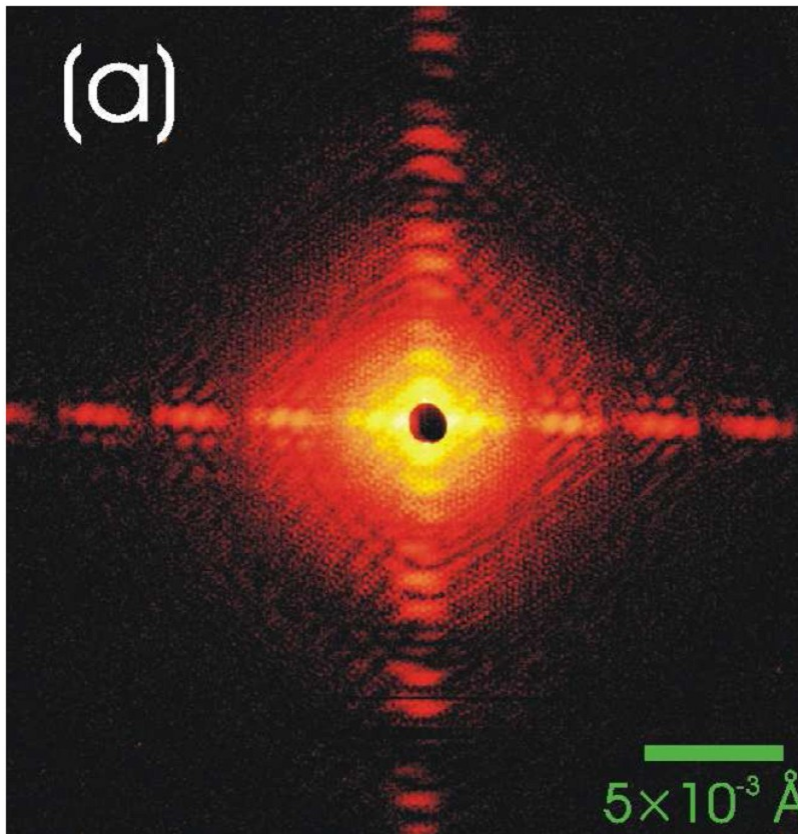


FTH (5)



▪ FTH (10)

Au reference structure (letter P): letter elements 200 nm in width and 220 nm height on 50 nm Si_3N_4 -membrane. 5 Au reference dots of 175 nm diameter and 220 nm height on a circle of 2.5 μm around the sample. 200x 3s exposures ($\approx 1.4 \times 10^8$ ph/s through $10 \times 10 \mu\text{m}^2$ at 8 keV).

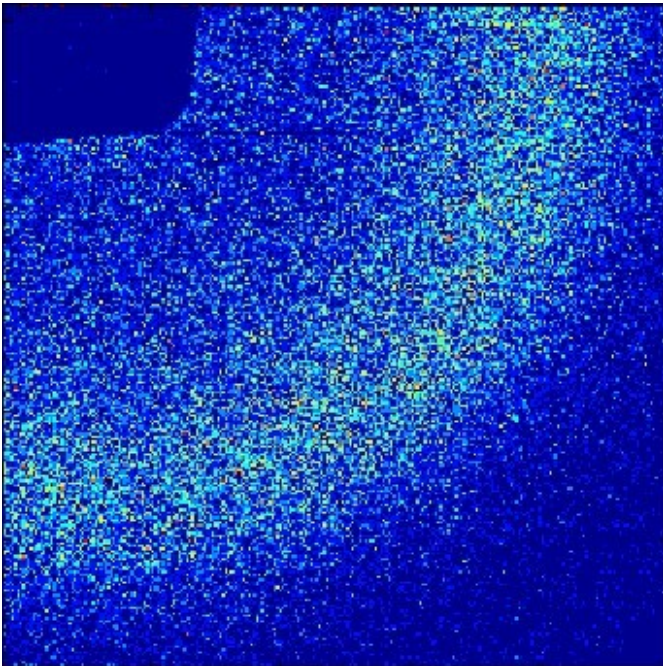


▪ (Magnetic) Scattering with coherent X-rays

If coherent light is scattered from a disordered system it gives rise to a random (grainy) diffraction pattern, known as “speckle”. A speckle pattern is an interference pattern and related to the exact spatial arrangement of the scatterers in the disordered system.

$$I(Q,t) \sim S_c(Q,t) \sim \left| \sum_{j \text{ in coherence volume } c} (f_j^{\text{charge}} + f_j^{\text{magnetic}}) e^{iQR_j(t)} \right|^2$$

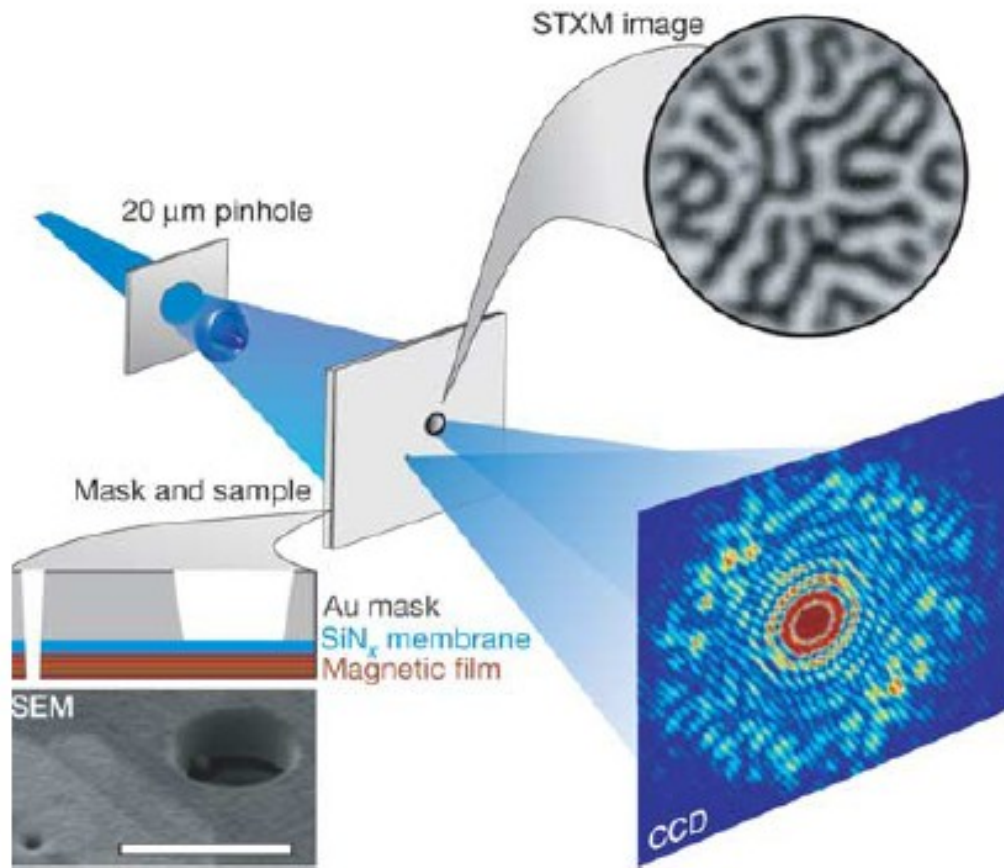
j in coherence volume $c = \xi_t^2 \xi_l$



Incoherent Light:

$$S(Q,t) = \langle S_c(Q,t) \rangle_{V \gg c} \quad \text{ensemble average}$$

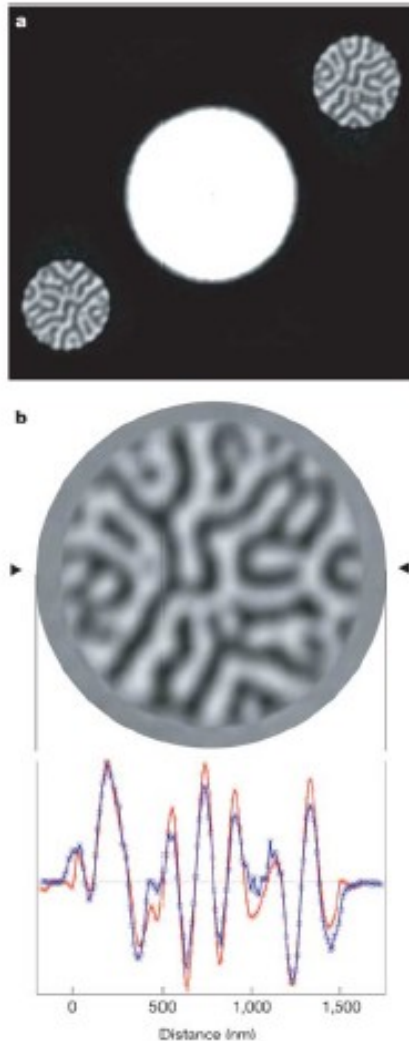
Fourier Transform Holography (1)



Random magnetic (stripe) domains in a [Co(4)Pt(7)]50 ML sample, illuminated together with a reference aperture (1.5 μm) at the Co LIII edge absorption edge with a 778 eV (1.59 nm) 20 μm coherent soft x-ray beam.

S. Eisebitt, J. Lüning, W.F. Schlotter, M. Lörger, O. Hellwig, W. Eberhardt and J. Stöhr,
NATURE, 432, 885 (2004)

Fourier Transform Holography (2)

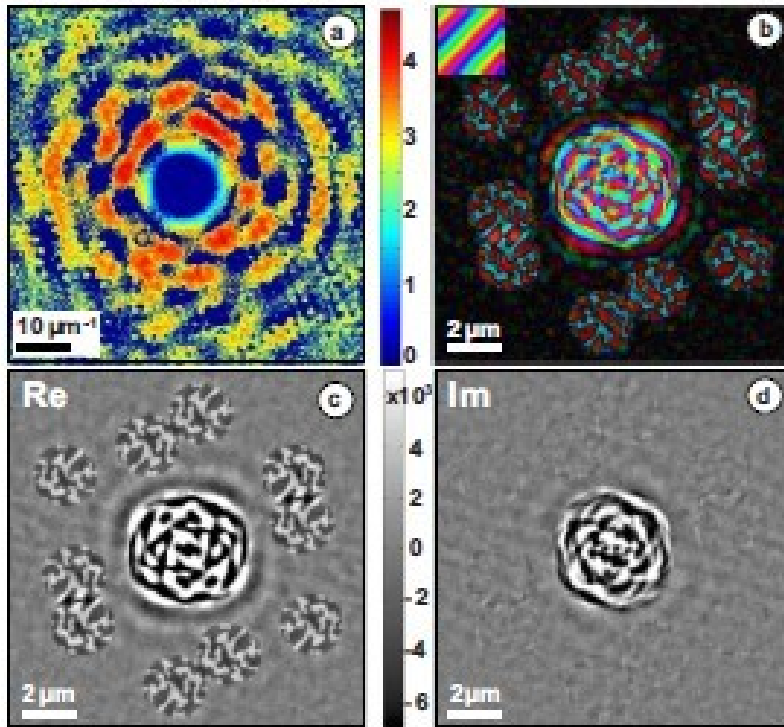


Reconstruction via direct 2-D Fourier transform of the [Co(4)Pt(7)]₅₀ speckle pattern (top). Difference pattern obtained from two reconstructed images recorded with different helicity (bottom) compared to line profiles through the difference pattern (red) and an STXM image (blue) revealing 50 nm resolution.

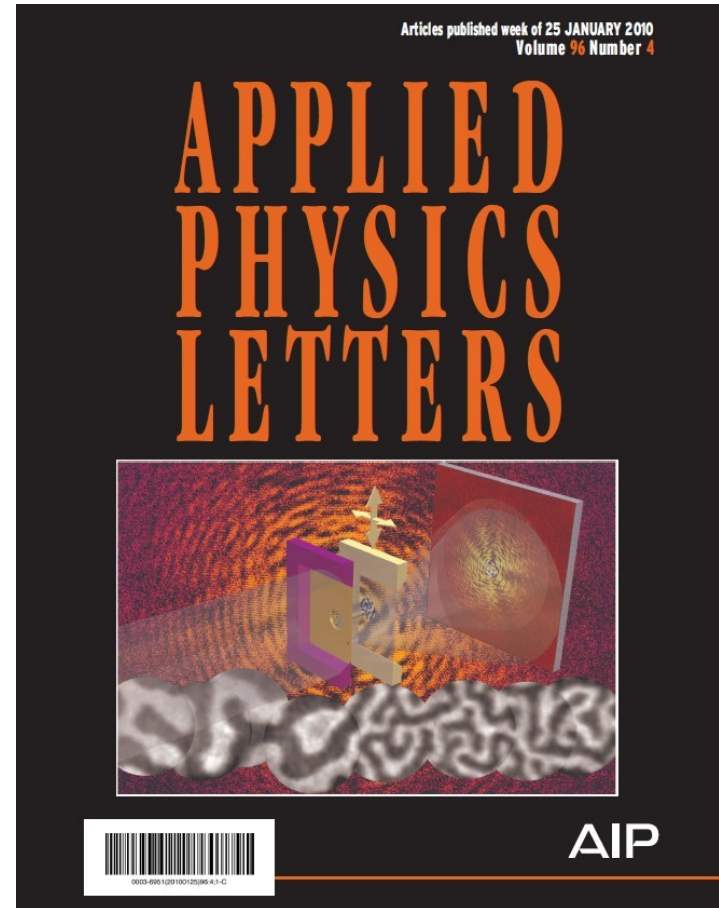
S. Eisebitt, J. Lüning, W.F. Schlotter, M. Lörger, O. Hellwig, W. Eberhardt and J. Stöhr, NATURE, 432, 885 (2004)

FTH at ESRF

use 5 reference apertures

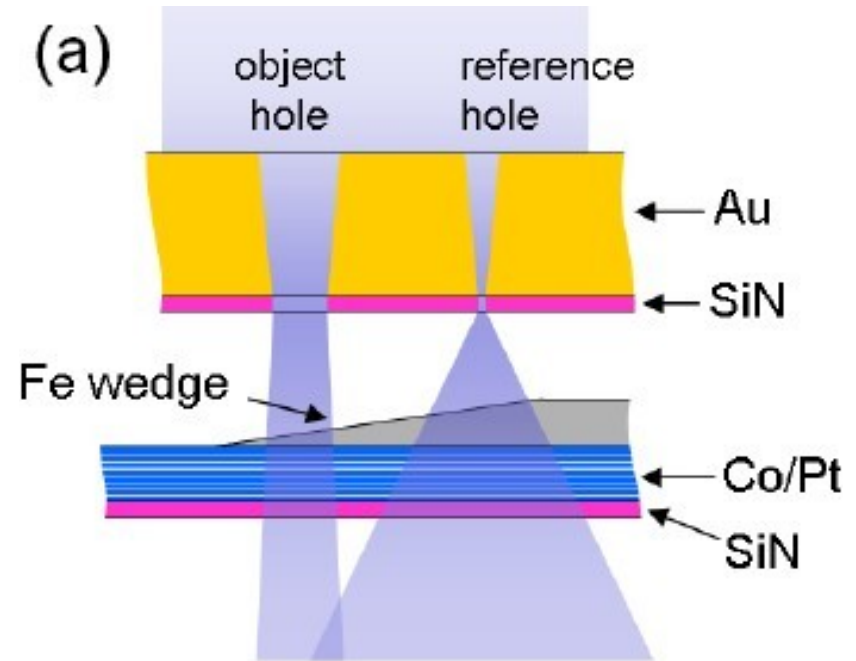
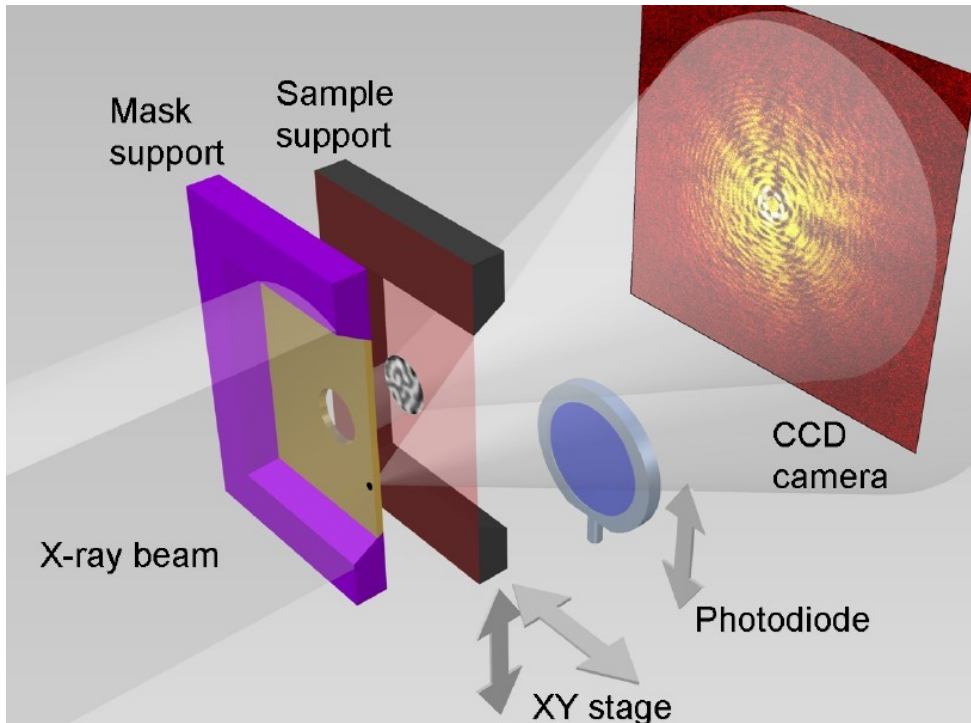


S. Streit-Nierobisch, D. Stickler, C. Gutt, L.-M. Stadler, H. Stillrich, C. Menk, R. Frömter, C. Tieg, O. Leupold, H. P. Oepen, and Grübel
JOURNAL OF APPLIED PHYSICS **106**, 1 (2009)



D. Stickler, R. Frömter, H. Stillrich, C. Menk, C. Tieg, S. Streit-Nierobisch, M. Sprung, C. Gutt, Lorenz-M. Stadler, O. Leupold, G. Grübel, and H. P. Oepen
APPLIED PHYSICS LETTERS **96**, 042501 (2010)

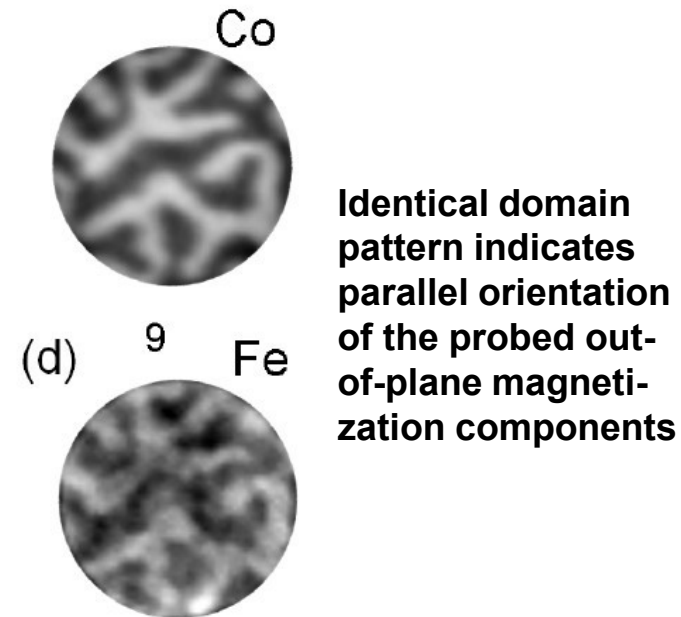
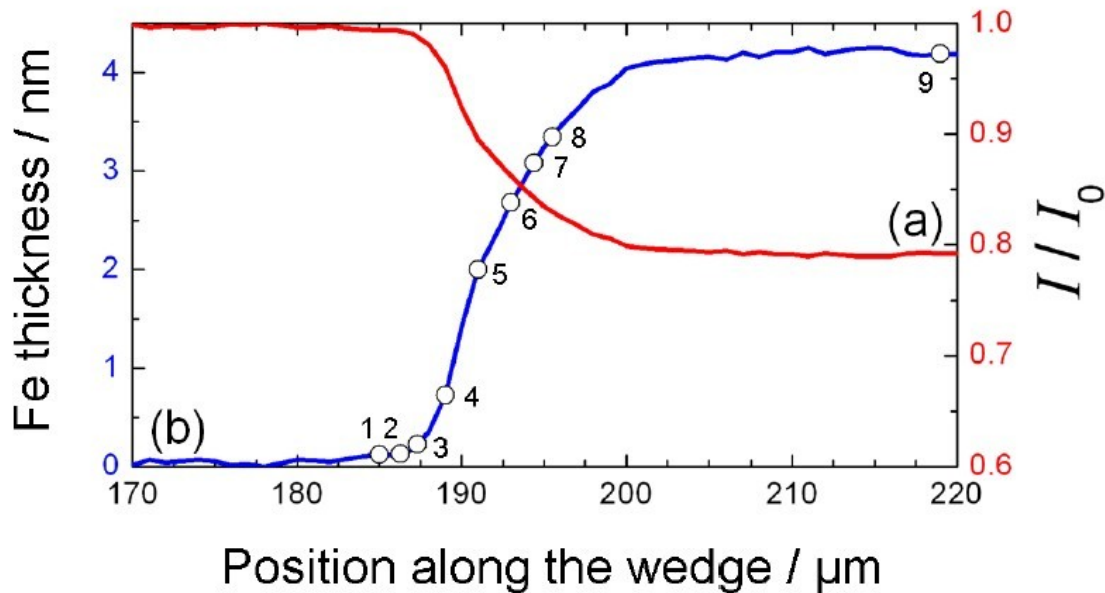
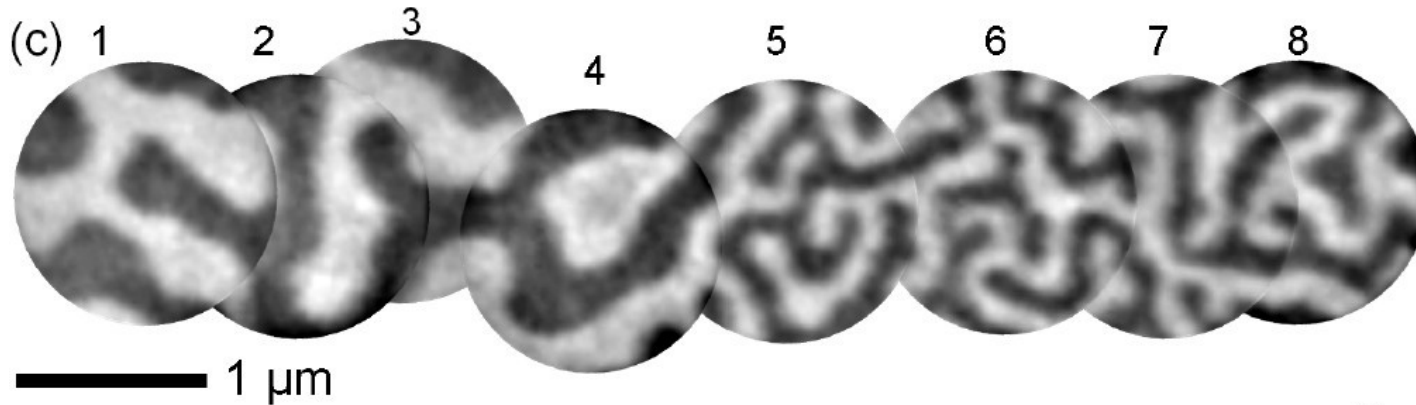
Soft X-ray holographic microscopy (I)



D. Stickler et al., APL **96**, 042501 (2010)

Soft X-ray holographic microscopy (II)

shift towards smaller domains with increasing thickness of Fe layer



X-Ray Photon Correlation Spectroscopy (XPCS)

analogous to Dynamic Light Scattering (DLS) or Photon Correlation Spectroscopy (PCS) with visible light

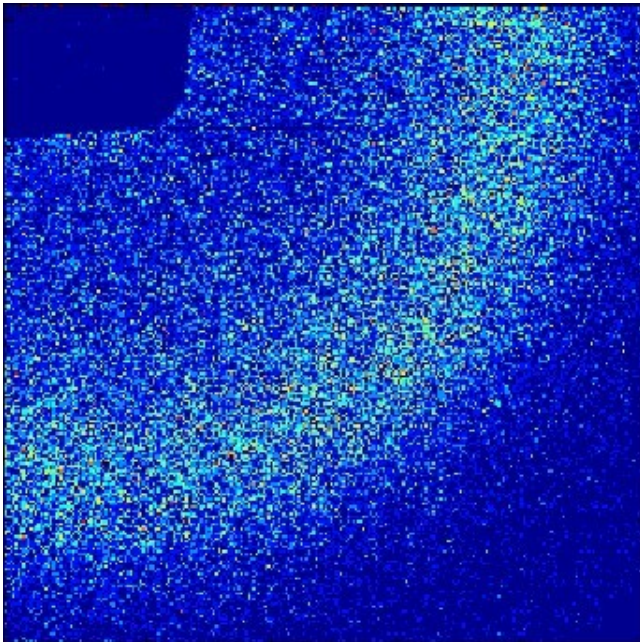
- gives access to larger momentum transfers ($Q_{\max} = 2\pi \cdot \sin\theta / \lambda$) or shorter lengthscales
- not subject to multiple scattering
- can be combined with the surface sensitivity of X-rays

Introduction: Scattering with coherent X-rays

If coherent light is scattered from a disordered system it gives rise to a random (grainy) diffraction pattern, known as “speckle”. A speckle pattern is an interference pattern and related to the exact spatial arrangement of the scatterers in the disordered system.

$$I(Q,t) \sim S_c(Q,t) \sim \left| \sum e^{iQR_j(t)} \right|^2$$

j in coherence volume $c = \xi_t^2 \xi_l$



Incoherent Light:

$$S(Q,t) = \langle S_c(Q,t) \rangle_{V \gg c} \quad \text{ensemble average}$$

- quantify dynamics in terms of the intensity correlation function $g_2(\mathbf{Q},t)$:

$$I(\mathbf{Q},t) = |\mathbf{E}(\mathbf{Q},t)|^2 = \left| \sum b_n(\mathbf{Q}) \exp[i\mathbf{Q} \cdot \mathbf{r}_n(t)] \right|^2$$

Note: $\mathbf{E}(\mathbf{Q},t) = \int d\mathbf{r}' \rho(\mathbf{r}') \exp [i\mathbf{Q} \cdot \mathbf{r}'(t)]$ $\rho(\mathbf{r}')$: charge density

$$g_2(\mathbf{Q},t) = \langle I(\mathbf{Q},0) \cdot I(\mathbf{Q},t) \rangle / \langle I(\mathbf{Q}) \rangle^2$$

if $\mathbf{E}(\mathbf{Q},t)$ is a zero mean, complex gaussian variable:

$$g_2(\mathbf{Q},t) = 1 + \beta(\mathbf{Q}) \langle \mathbf{E}(\mathbf{Q},0) \mathbf{E}^*(\mathbf{Q},t) \rangle^2 / \langle I(\mathbf{Q}) \rangle^2$$

$\langle \rangle$ ensemble av.; $\beta(\mathbf{Q})$ contrast

$$g_2(\mathbf{Q},t) = 1 + \beta(\mathbf{Q}) |f(\mathbf{Q},t)|^2$$

with $f(\mathbf{Q},t) = F(\mathbf{Q},t) / F(\mathbf{Q},0)$

$F(\mathbf{Q},0)$: static structure factor

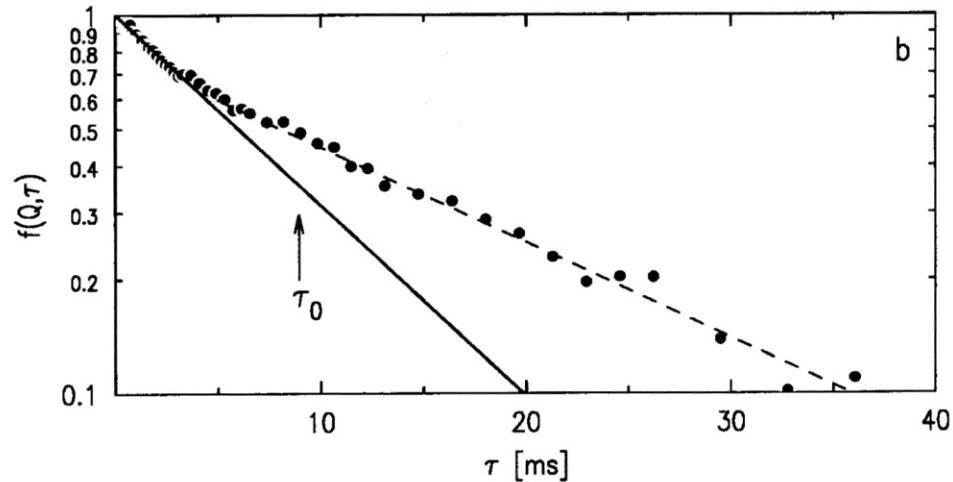
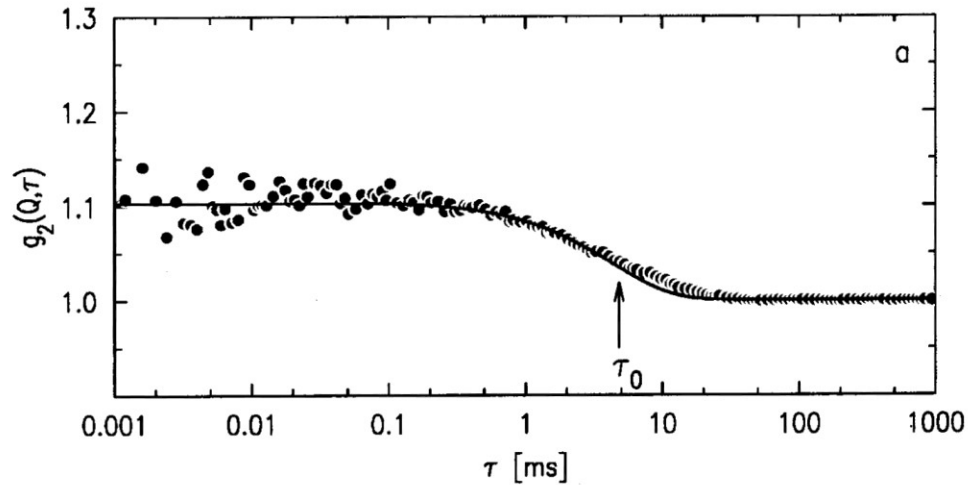
N : number of scatterers

$$F(\mathbf{Q},t) = [1/N \{b^2(\mathbf{Q})\}] \left| \sum_{m=1}^N \sum_{n=1}^N \langle b_n(\mathbf{Q}) b_m(\mathbf{Q}) \bullet \exp\{i\mathbf{Q}[\mathbf{r}_n(0) - \mathbf{r}_m(t)]\} \rangle \right|^2$$

- A time correlation function $g_2(\mathbf{Q}, \tau)$

$$g_2(\mathbf{Q}, t) = 1 + \beta(\mathbf{Q}) |f(\mathbf{Q}, t)|^2 \quad \text{and} \quad f(\mathbf{Q}, t) = \exp(-\Gamma t) = \exp(-t/\tau)$$

$\beta(\mathbf{Q})$ \updownarrow



▪

Examples:

Dynamics of interacting colloidal particles

Dynamics in heterodyne mode detection

Dynamics at surfaces/interfaces

Dynamics (of a liquid crystalline system) near a phase transition

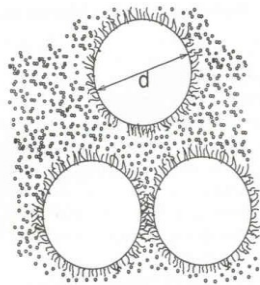
Non-equilibrium dynamics

...

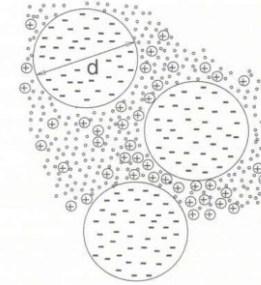
Dynamics of interacting Colloidal Particles

Colloidal particles (paints, ink, clays,silica,.....) suspended in a solvent (molecular fluid, ...). Stabilised against van der Waals“ attraction.

„Hard Spheres“



„Soft Spheres“



Structure: $S(Q) = 1 + 4\pi\rho \int [g\{r\} - 1] (\sin(Qr)/Qr) r^2 dr$; $g\{r\} = \exp[-V(r)/kT]$ ρ : number density

$\Phi \ll 1\%$:

$$S(Q) = 1$$

$$D(Q) = D_0 (=kT/6\pi\eta R_H)$$

$\Phi > 1\%$:

$$V(r) = \begin{cases} 0 & r \geq d \\ \infty & r < d \end{cases}$$

weak interaction: DLVO

$$V(r) \propto (eZ_{eff})^2/r \exp(-\kappa r)$$

$$S = S(Q, \Phi) \text{ (Percus-Yevick)}$$

$$S = S(Q, \Phi, Z_{eff}, \kappa) \text{ (MSA, RMSA)}$$

Dynamics: Interaction: colloid-solvent, colloid-colloid, hydrodynamics

Smoluchowski (many particle) diffusion equation:

$$D_{\text{short}}(Q) = D_0/S(Q) * H(Q) \quad t \ll R^2/D_0$$

$$H(Q) \text{ (Beenakker and Mazur)}$$

$$H(Q) \text{ (via } D_0, S(Q), D(Q) \text{)}$$

(Time averaged) Structure

Correlation lengths \approx particle size \rightarrow

Small Angle X-ray Scattering (SAXS)

$(d\sigma/d\Omega)/V = r_o^2 n (\rho_p - \rho_s)^2 v^2 P(Q) S(Q)$ monodisperse, spherical particles

n: volume fraction, ρ : electron densities, v: particle volume

$P(Q) = [3/(QR)^3]^2 [\sin(QR) - (QR)\cos(QR)]^2$ sphere form factor

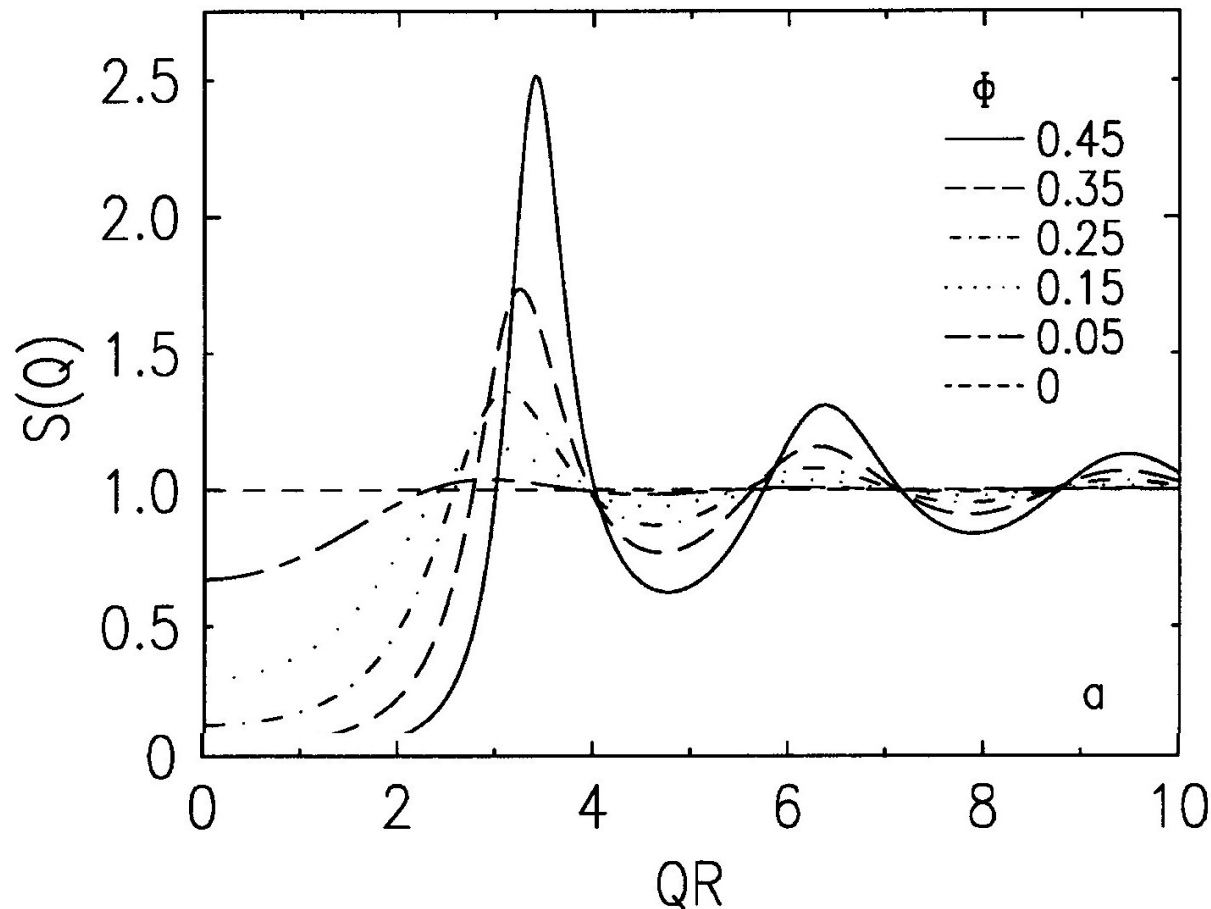
$S(Q) = 1 + 4\pi n \int [g(r) - 1] \sin(QR)/QR r^2 dr$ structure factor

$g(r) = \exp [V(r) / kT]$

Structure (the Hard Sphere case)

$$V(r) = 0 \quad \text{for } r \geq d;$$

$$V(r) = \infty \quad \text{for } r < d$$

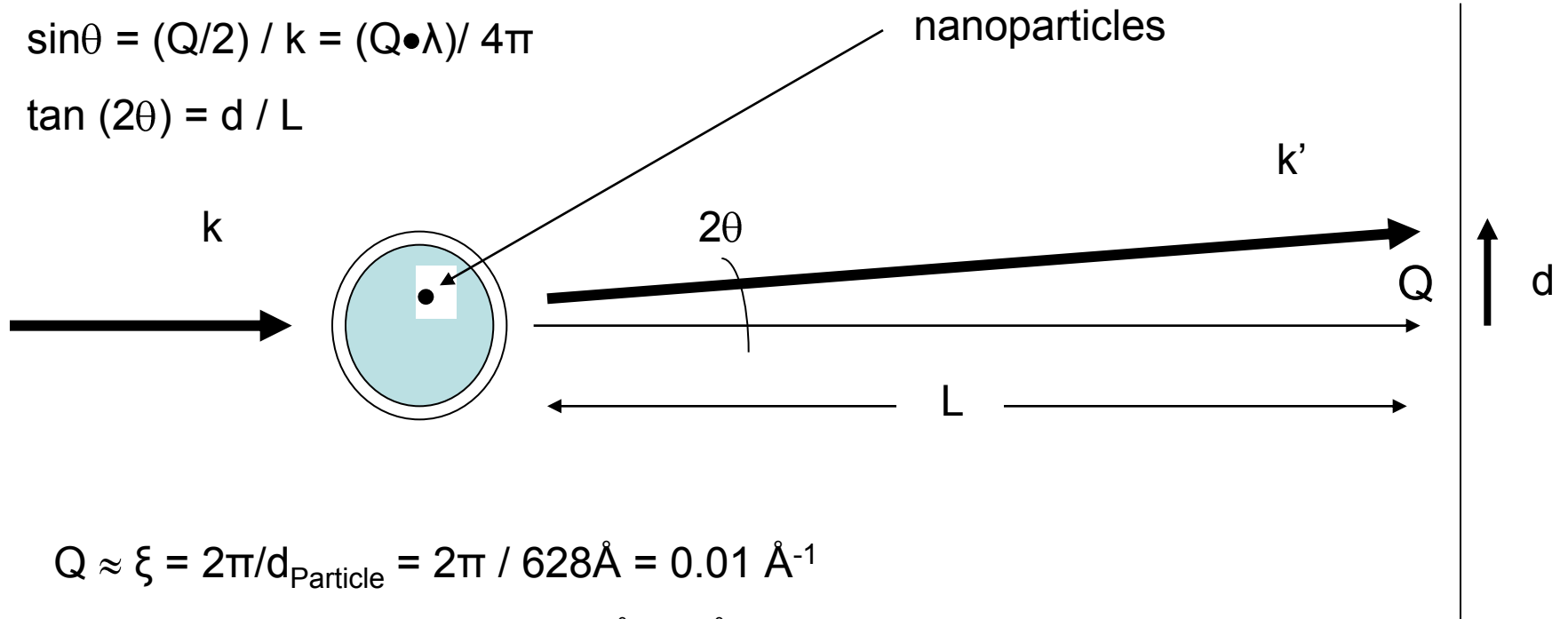


Percus-Yevick $S(Q)$

Small Angle X-ray Scattering (SAXS)

$$\sin\theta = (Q/2) / k = (Q \cdot \lambda) / 4\pi$$

$$\tan(2\theta) = d / L$$



$$Q \approx \xi = 2\pi/d_{\text{Particle}} = 2\pi / 628\text{\AA} = 0.01 \text{\AA}^{-1}$$

$$\theta = \sin^{-1}(Q \cdot \lambda / 4\pi) = \sin^{-1}(0.01\text{\AA}^{-1} \cdot 1\text{\AA} / 4\pi) \approx 0.0456 \text{ deg}$$

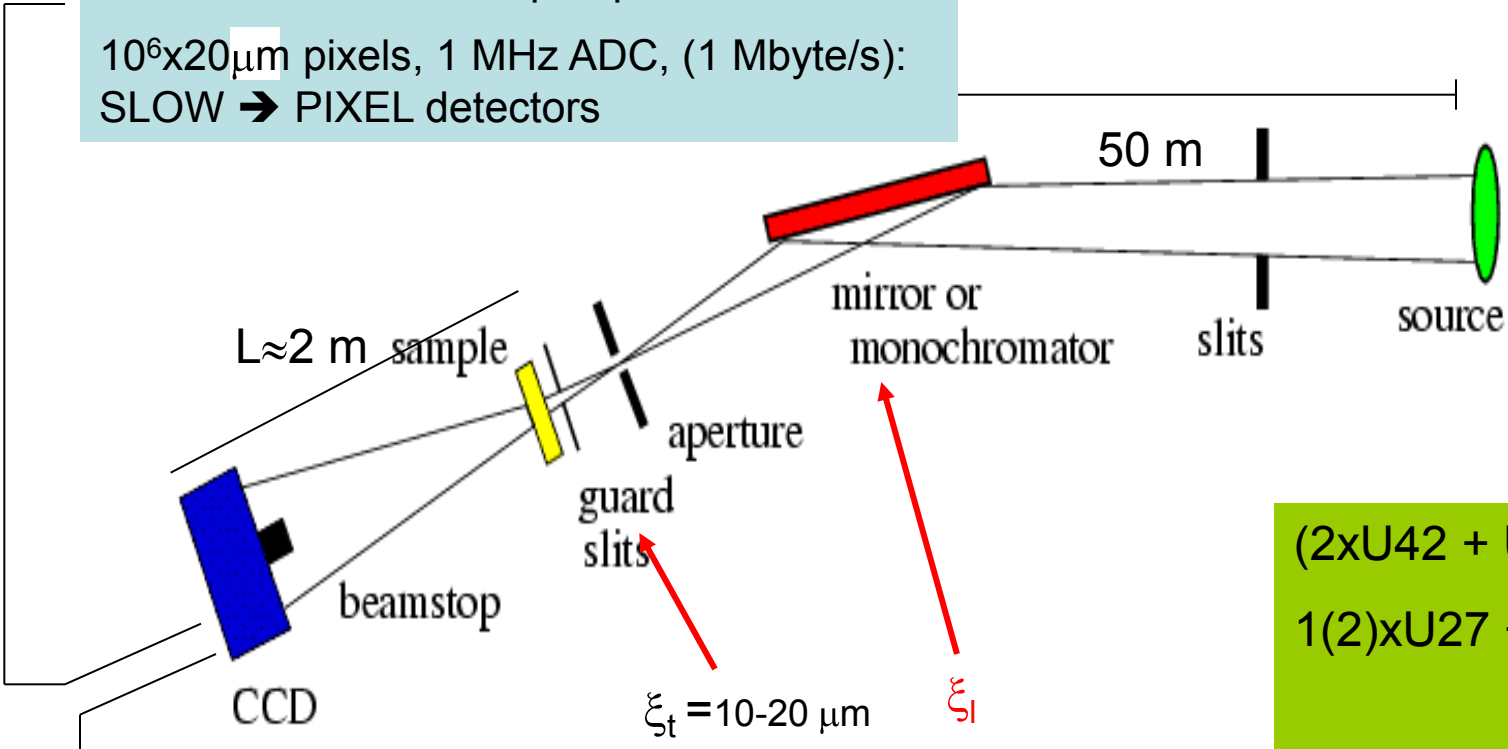
$$d = L \cdot \tan(2\theta) = 2 \text{ m} \cdot 1.58 \cdot 10^{-3} = 3.183 \text{ mm}$$

screen

2-D detector

Beamline for coherent scattering: ID10A @ ESRF

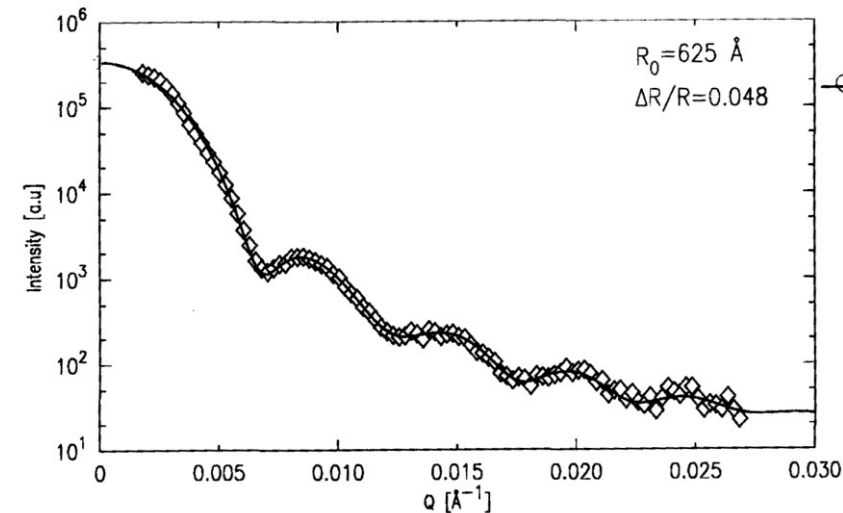
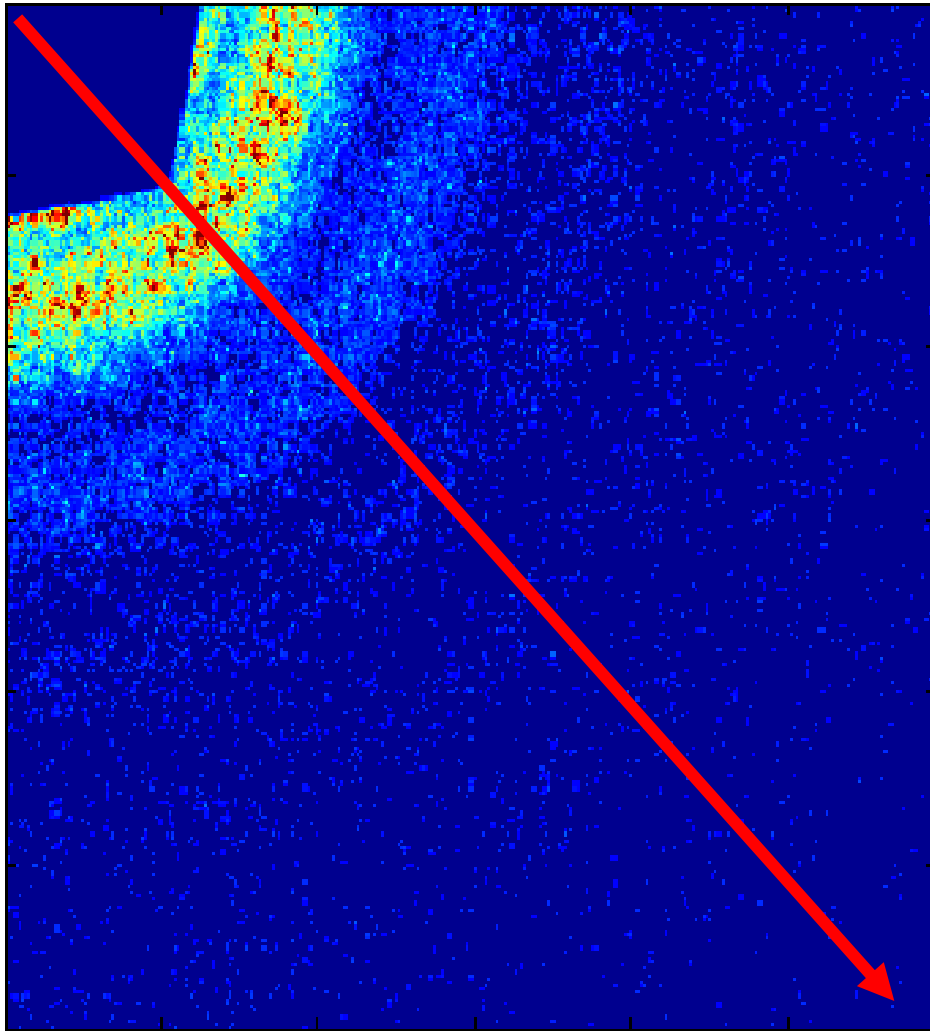
2-D detector
 Direct illumination, deep depletion CCD
 $10^6 \times 20 \mu\text{m}$ pixels, 1 MHz ADC, (1 Mbyte/s):
 SLOW \rightarrow PIXEL detectors



(2xU42 + U26)
 1(2)xU27 + 2(1)xU35

0-D detector
 + digital autocorrelator: FAST
 speckle size: $(\lambda/\xi_t) \cdot L \approx 20\text{-}40 \mu\text{m}$

- colloidal silica particles undergoing Brownian motion in high viscosity glycerol ($R = 2610 \text{ \AA}$, $\Delta R/R=0.03$, 10 vol% in glycerol, $T=-13.6\text{C}$, $\eta \approx 56000 \text{ cp}$)



V. Trappe and A. Robert

▪ Brownian Motion of Colloidal Particles

$$f(\mathbf{Q},t) = F(\mathbf{Q},t) / F(\mathbf{Q},0)$$

$$F(\mathbf{Q},t) = [1/N\{b^2(\mathbf{Q})\}] |\sum_{m=1}^N \sum_{n=1}^N \langle b_n(\mathbf{Q}) b_m(\mathbf{Q}) \bullet \exp\{i\mathbf{Q}[\mathbf{r}_n(0) - \mathbf{r}_m(t)]\} \rangle$$

mean square displacement:

$$\langle [\mathbf{r}(0) - \mathbf{r}(t)]^2 \rangle = 6 D_0 t$$

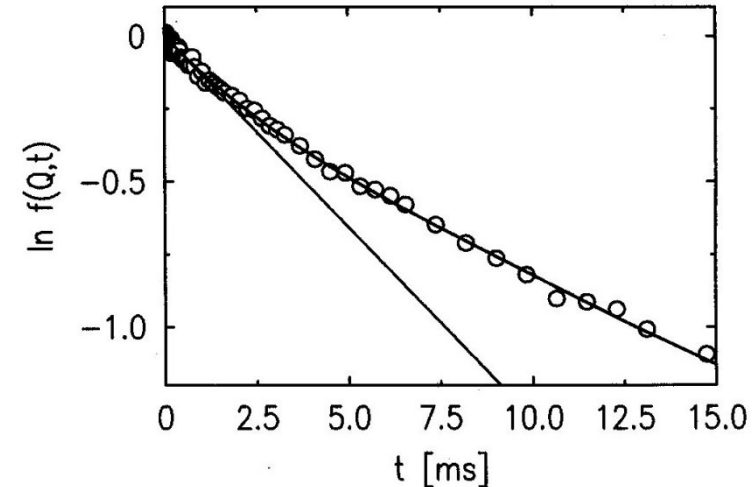
$$\text{with } D_0 = k_B T / 6\pi\eta R$$

D_0 free particle (Stokes-Einstein) diffusion coefficient, η shear viscosity

$$f(\mathbf{Q},t) = \exp(-\Gamma \bullet t) = \exp(-D_0 \mathbf{Q}^2 t)$$

in general:

$$D = D(\mathbf{Q},t) \quad \text{with} \\ = \lim_{t \rightarrow 0} d/dt [\ln \{f^{\text{measured}}(\mathbf{Q},t)\}] = -D(\mathbf{Q}) \bullet \mathbf{Q}^2$$

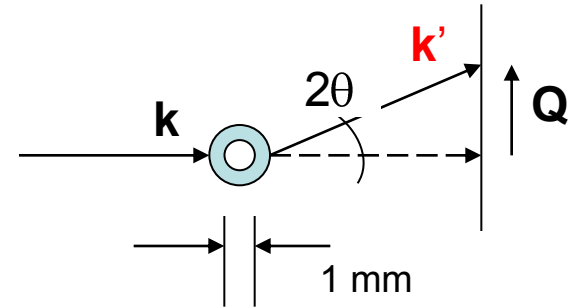
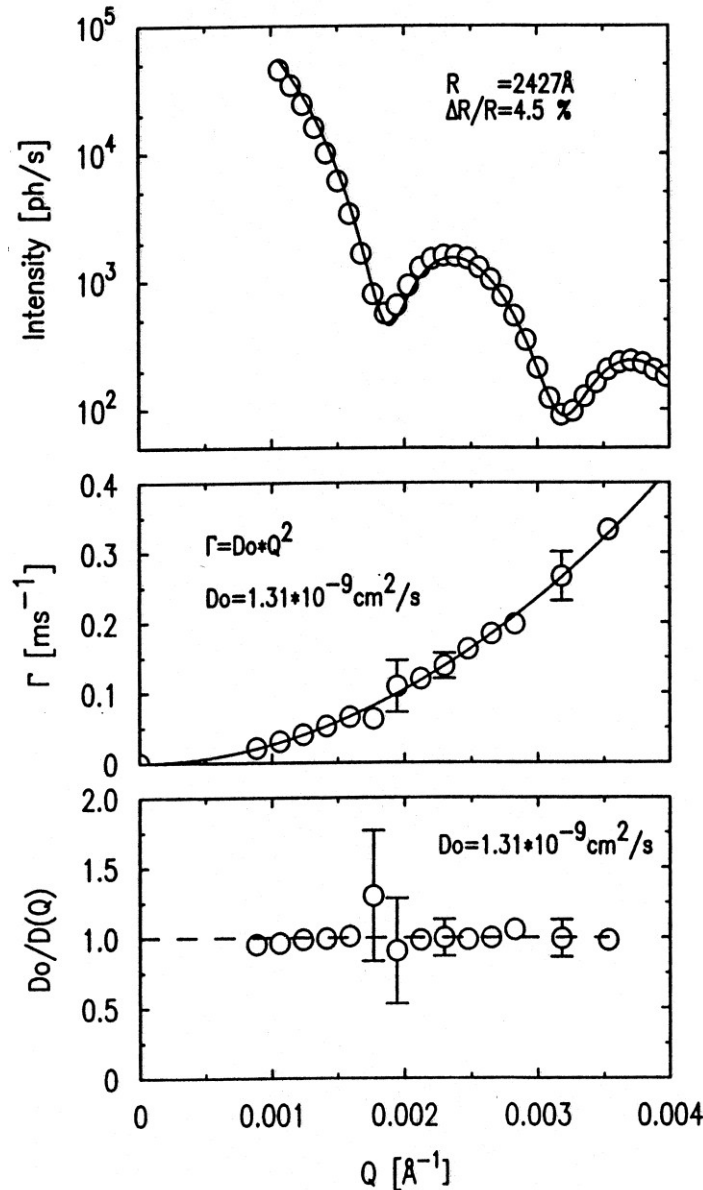


The dilute case

$$I \sim |F(Q)|^2 S(Q)$$

$$\sim [(\sin QR - QR \cos QR) / (QR)^3]^2$$

$$\Gamma = D_0 Q^2$$



$$Q = k' - k$$

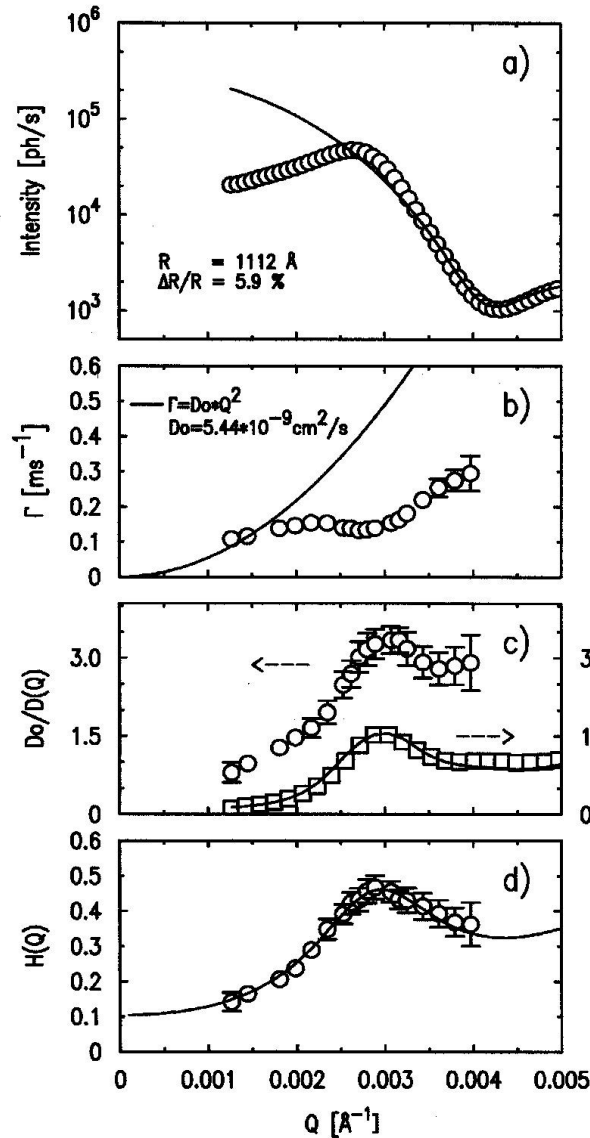
$$Q = 2k \sin \theta$$

$$k = 2\pi/\lambda$$

G. Grübel, A. Robert, D. Abernathy
 8th Tohwa University International
 Symposium on "Slow Dynamics in
 Complex Systems", 1998, Fukuoka, Japan

▪ The Hard Sphere Case

Poly-
methylmetacrylate
37% volume fraction
in cis-decaline
sterically stabilized
(**hard-spheres**)



--- $F(Q)$

--- $\Gamma = D_0 Q^2$

$S(Q) = I(Q)/F(Q)$

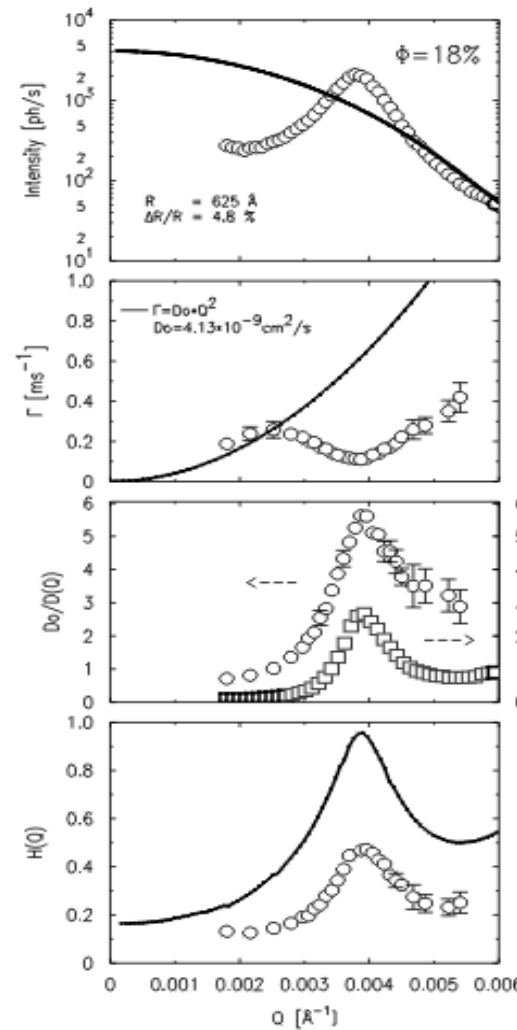
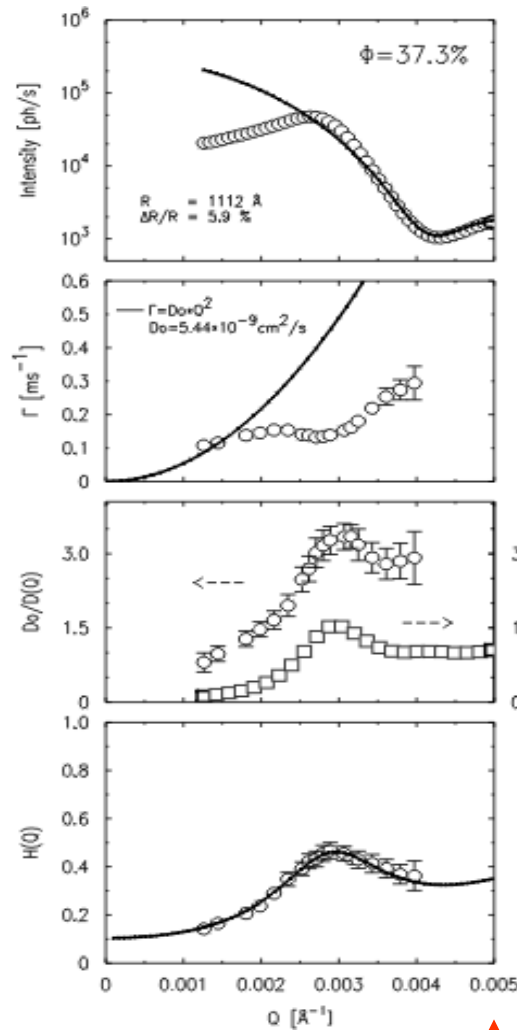
caging (deGennes
narrowing)

$H(Q) = S(Q) / [D_0 / D(Q)]$

--- δ - γ expansion

Poly-methylmetacrylate
 37% volume fraction in cis-decaline
 sterically stabilized (**hard-spheres**)

Poly-octafluoropentylcrylate
 18% volume fraction in H₂O/glycerol
 charge-stabilized (**soft-spheres**)



“caging“
 (deGennes
 narrowing)

δ-γ expansion

$$|F(Q)|^2$$

$$\Gamma = D_0 Q^2$$

$$S(Q) = I(Q) / |F(Q)|^2$$

δ-γ expansion

$$H(Q) = S(Q) / [D_0/D(Q)]$$

no model

↑ **QR=5.6**

Zontone, Moussaid, Robert, Grübel

Robert, Härtl, Wagner, Grübel

■

Surface Dynamics studied with XPCS